

Shenzhen Most Technology Service Co., Ltd.

No.5, 2nd Langshan Road, North District, Hi-tech Industrial Park, Nanshan, Shenzhen, Guangdong, China.

RF Exposure Evaluation Report

Compiled by

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Date of issue...... Aug. 27,2024

Representative Laboratory Name.: Shenzhen Most Technology Service Co., Ltd.

Nanshan, Shenzhen, Guangdong, China.

Sunny Deng

Applicant's name..... XIAMEN LIYIN TECHNOLOGY CO.,LTD

Address...... 5F,NO.68,South Sunban Road Jimei,xiamen,Fujian,china

Test specification/ Standard..........: 47 CFR Part 1.1307

47 CFR Part 2.1093

TRF Originator...... Shenzhen Most Technology Service Co., Ltd.

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Test item description.....: MINI A4 PRINTER

Trade Mark.....: N/A

Model/Type reference..... MP850

Listed Models MP850S、MP860、MP860S、P8、P8S、M1、M2、M3、Q1、

Q2、Q3、A4、A4HD

Modulation Type.....: GFSK

GFSK, π/4DQPSK, 8DPSK

Operation Frequency...... From 2402MHz to 2480MHz

Hardware Version..... MP850 V3.0

Software Version...... MP850-RM

Rating..... DC 7.2V by Battery
DC 5V by USB Port

Result..... PASS

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TEST REPORT

Equipment under Test : MINI A4 PRINTER

Model /Type : MP850

Remark

Listed Models : MP850S、MP860、MP860S、P8、P8S、M1、M2、M3、Q1、

. Q2、Q3、A4、A4HD

Only the model MP850 was tested, since the electrical circuit

design, layout, components used and internal wiring were identical

for the above models, Just the model name and the appearance

color is different.

Applicant : XIAMEN LIYIN TECHNOLOGY CO.,LTD

Address : 5F,NO.68,South Sunban Road Jimei,xiamen,Fujian,china

Manufacturer : XIAMEN LIYIN TECHNOLOGY CO.,LTD

Address 5F,NO.68,South Sunban Road Jimei,xiamen,Fujian,china

Test Result: PASS

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

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1. Revision History

Revision	Issue Date	Revisions	Revised By
00	2024.08.27	Initial Issue	Alisa Luo

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2. SAR Evaluation

2.1 RF Exposure Compliance Requirement

2.1.1 Standard Requirement

According to KDB447498D01 General RF Exposure Guidance v06

4.3.1. Standalone SAR test exclusion considerations

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Exclusion Threshold condition, listed below, is satisfied.

2.1.2 Limits

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] • [$\sqrt{f(GHz)}$] ≤ 3.0 for 1-g SAR and ≤ 7.5 for 10-g extremity SAR, where

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation¹⁷

The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is \leq 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is \leq 5 mm, a distance of 5 mm is applied to determine SAR test exclusion

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2.1.3 EUT RF Exposure

Measurement Data

BLE

GFSK					
Test channel	Peak Output Power	Tune up tolerance	Maximum tune-up Power		
1 000 011011101	(dBm)	(dBm)	(dBm)		
Lowest(2402MHz)	1.452	1.452±1	2.452		
Middle(2440MHz)	1.808	1.808 ± 1	2.808		
Highest(2480MHz)	2.914	2.914±1	3.914		

Worst case: GFSK						
Channel	Maximum Peak Conducted Output	Maximun Pov		Calculated	Exclusion	SAR Test
Power (dBm)	(dBm)	(mW)	value threshol	threshold	Exclusion	
Highest(2480MHz)	2.914	3.914	2.46	0.77	3.0	Yes

EDR

LDIX					
GFSK					
Test channel	Peak Output Power	Tune up tolerance	Maximum tune-up Power		
	(dBm)	(dBm)	(dBm)		
Lowest(2402MHz)	-0.586	-0.586±1	0.414		
Middle(2441MHz)	-0.462	-0.462±1	0.538		
Highest(2480MHz)	-1.006	-1.006±1	-0.006		

π/4DQPSK					
Test channel	Peak Output Power	Tune up tolerance	Maximum tune-up Power		
Test chamier	(dBm)	(dBm)	(dBm)		
Lowest(2402MHz)	0.356	0.356±1	1.356		
Middle(2441MHz)	0.475	0.475±1	1.475		
Highest(2480MHz)	-0.060	-0.060±1	0.94		

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8DPSK					
Test channel	Peak Output Power	Tune up tolerance	Maximum tune-up Power		
	(dBm)	(dBm)	(dBm)		
Lowest(2402MHz)	0.774	0.774 ± 1	1.774		
Middle(2441MHz)	0.866	0.866±1	1.866		
Highest(2480MHz)	0.322	0.322±1	1.322		

Worst case: 8DPSK						
Channel	Maximum Peak Conducted Output	Maximun Pov	-	Calculated	Exclusion	SAR Test
Power (dBm)	(dBm)	(mW)	value threshold	threshold	Exclusion	
Middle(2441MHz)	0.866	1.866	1.54	0.48	3.0	Yes

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